

Search Notes 	Application/Control No. 10/671,309	Applicant(s)/Patent under Reexamination HAYAKAWA ET AL.
	Examiner Mark Kopec	Art Unit 1751

ABOVE TO DATE 2/2/06 m

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
P6 PwB		2/2/06	m

SEARCH NOTES (INCLUDING SEARCH STRATEGY)